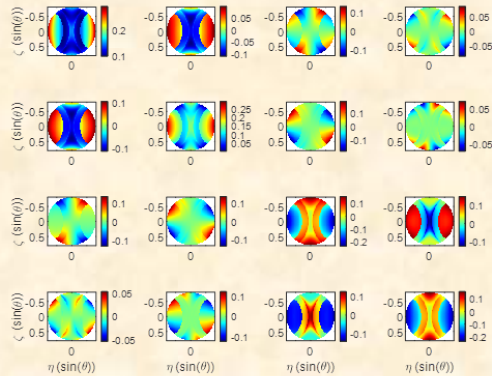


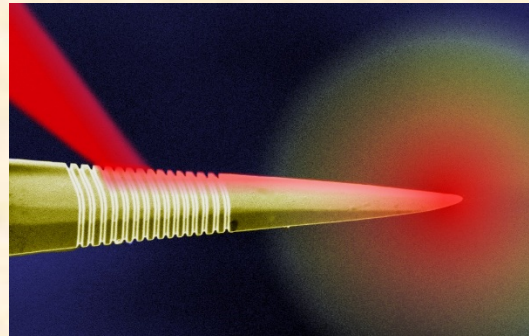
Workpackage 1: Far field metrology within the Rayleigh regime

To select and exploit the essential information that can be extracted from the interaction of a light probe and an unknown object by taking advantage of all possible degrees of freedom that intervene in a light-matter interaction process.



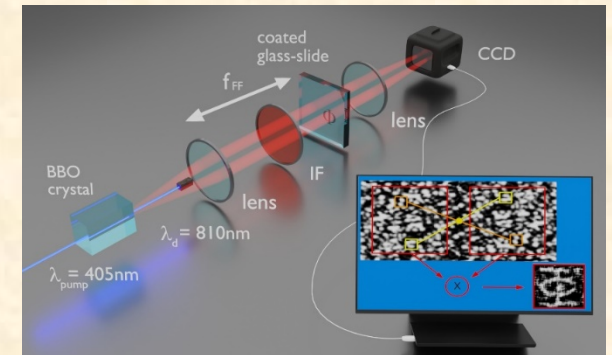
Workpackage 2: Inelastic, non-linear and resonant optical metrology

To exploit and make available the potential of inelastic, nonlinear and resonant processes to enhance diffraction-based optical methods, to provide novel or improved super-resolution microscopy methods for universal metrology applications.



Workpackage 3: Innovative imaging methods by light shaping in the classical and quantum domains

To exploit the spatial degree of freedom of a light field, both in the classical and quantum domains. Engineered states of light hold the potential to largely increase the sensitivity of measurements of specific geometrical or physical parameters of a nano-target.



T1.1: Multidimensional (spatial, spectral, polarization-based) techniques and structured illumination

T1.2: Inverse scattering, advanced inversion and inference methods

T1.3: Traceability for optical metrology within the Rayleigh regime

T2.1: Metamaterials-enhanced and resonant scattering methods

T2.2: Super-resolution Raman imaging and Raman scatterometry

T2.3 Label-free super-resolution imaging

T2.4: Traceability for optical metrology within the inelastic scattering regime

T3.1: Quantitative phase retrieval in classical and quantum regime

T3.2: Quantum structured illumination

T3.3: Traceability for phase-sensitive optical metrology within the classical and quantum domains

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EMPIR/EURAMET Project 20FUN02

The goal of the project is to develop new optical measurement techniques for the investigation of structures at the nanoscale with traceable spatial resolution beyond classical limits and sub-nanometre accuracy. Approaches to higher resolution systems include:

- the development of new “metamaterial” structures;
- near-field methods;
- quantum optics techniques that exploit photon entanglement;
- the decoding of other information contained in optical waves
- universal label-free super-resolution microscopy



The EMPIR initiative is co-funded by the European Union's Horizon 2020 research and innovation programme and the EMPIR Participating States



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